

Notice of References Cited	Application/Control No. 10/624,759	Applicant(s)/Patent Under Reexamination WEN ET AL.	
	Examiner Sangwoo Ahn	Art Unit 2166	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,349,296	02-2002	Broder et al.	707/3
	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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